

IFW

00005.001286

PATENT APPLICATION



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

re Application of:

AKIRA MIIKE, ET AL.

Application No.: 10/567,843

Filed: February 10, 2006

For: DEVICE FOR MEASUREMENT OF  
OBJECT TO BE MEASURED,  
APPARATUS FOR  
MEASUREMENT AND METHOD  
OF MEASUREMENT

)  
:  
) Examiner: Not Yet Assigned

)  
:  
) Group Art Unit: Not Yet Assigned

)  
:  
)  
:  
) June 22, 2006

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

SUBMISSION OF MISCELLANEOUS PCT FORMS


Sir:

Enclosed to complete the record and for the Examiner's convenience is Form PCT/IB/338, an English translation of the International Preliminary Report on Patentability (Form PCT/IB/373) and the Written Opinion of the International Searching Authority (Form PCT/ISA/237) in the above-identified application. The references discussed in the Written Opinion are all cited in Applicants' June 22, 2006 Information Disclosure Statement being filed currently herewith.

Entry hereof is earnestly solicited.

Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our below listed address.

Respectfully submitted,



Lawrence S. Perry  
Attorney for Applicants  
Registration No. 31,865

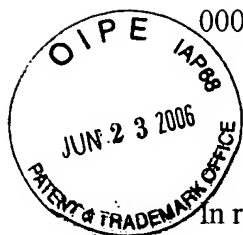
FITZPATRICK, CELLA, HARPER & SCINTO  
30 Rockefeller Plaza  
New York, New York 10112-3801  
Facsimile: (212) 218-2200

LSP\ac

NY\_Main 576527\_1

00005.001286

PATENT APPLICATION



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	)	
	:	Examiner: Not Yet Assigned
AKIRA MIIKE, ET AL.	)	
	:	Group Art Unit: Not Yet Assigned
Application No.: 10/567,843	)	
	:	
Filed: February 10, 2006	)	
	:	
For: DEVICE FOR MEASUREMENT	)	
OF OBJECT TO BE MEASURED,	:	
APPARATUS FOR	)	
MEASUREMENT AND	:	
METHOD OF MEASUREMENT	)	June 22, 2006

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the listed documents are also enclosed.

Documents A-D, J and K are cited at specification pages 2-3. Their relevance is discussed therein. For the Examiner's convenience, documents A and I are respectively family member equivalents of JP-A-1-35269 and JP-T-1503174, both cited at specification page 3. (Document I is also a family member equivalent of JP 8-511621 and EP 0705426 cited in the International Search Report.) Documents F-H are cited in the International Search Report.

CONCLUSION

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

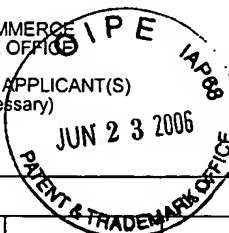
Applicants' undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,

  
Lawrence S. Perry  
Attorney for Applicants  
Registration No. 31,865

FITZPATRICK, CELLA, HARPER & SCINTO  
30 Rockefeller Plaza  
New York, New York 10112-3800  
Facsimile: (212) 218-2200

LSP\ac

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)ATTY DOCKET NO.  
**00005.001286**APPLICATION NO.  
**10/567,843**APPLICANT  
**AKIRA MIIKE, ET AL.**FILING DATE  
**February 10, 2006**GROUP  
**Not Yet Assigned**

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	<b>A</b>	<b>4,847,193</b>	<b>7/89</b>	<b>Richards, et al.</b>	<b>435</b>	<b>6</b>	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
	<b>B</b>	<b>64-032169</b>	<b>2/89</b>	<b>Japan</b>			<b>Abstract</b>
	<b>C</b>	<b>WO 88/08534</b>	<b>11/88</b>	<b>PCT</b>			
	<b>D</b>	<b>64-063865</b>	<b>3/89</b>	<b>Japan</b>			<b>Abstract</b>
	<b>E</b>	<b>10-073526</b>	<b>3/98</b>	<b>Japan</b>			<b>Abstract</b>
	<b>F</b>	<b>2002-122597</b>	<b>4/02</b>	<b>Japan</b>			<b>Abstract</b>
	<b>G</b>	<b>07-225233</b>	<b>8/95</b>	<b>Japan</b>			<b>Abstract</b>
	<b>H</b>	<b>2002-310874</b>	<b>10/02</b>	<b>Japan</b>			<b>Abstract</b>
	<b>I</b>	<b>WO 94/29696</b>	<b>12/94</b>	<b>PCT</b>			
	<b>J</b>	<b>73592/98</b>	<b>3/98</b>	<b>Japan</b>			<b>Abstract</b>

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	<b>K</b>	<b>Muramatsu, et al., "Piezoelectric Crystal Biosensor Modified with Protein A for Determination of Immunoglobulins", Anal. Chem., Vol. 59, No. 23, pages 2760-2763</b>					

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1